Editorial Forward Issue No. 28

April 30, 2014 (E28). Issue No. 28 of SNF is probably the last published at the current website. The new, largely re-designed SNF website at a different URL is presently in testing and will be launched in the very near future. Nevertheless, the present website will be maintained for the rest of 2014 without being updated anymore. We apologize for any possible inconvenience in this upcoming transition period, and ask our readers for patience in cases they have to visit both sites to find the desired material.

The current Issue does not include any conference paper preprints, but presents the summary overview CRP41 of talks on wire and tape conductors and their characterization given at the International Symposium on Superconductivity (ISS 2013) held in Tokyo, Japan, from November 18th to 20th, 2013. The Proceedings of that meeting will be published in an online issue of *Physics Procedia* (Elsevier) to be published in June 2014, and in a special issue of *Physica C* (Elsevier) which will be published in October 2014. The summary overview, in the form of a slide presentation, was prepared by Sang-Soo Oh (KERI) and Teruo Izumi (ISTEC). Also included is the presentation STP380 on round core magnet cables by Danko van der Laan et al., given at the past MT-23 Conference (Boston, July 2013). Finally, we pre-publish a paper (preprint ST379) on a ghost artifact in ultra-low-field magnetic resonance relaxation imaging (ULF-MRRI) by P. Volegov et al. This paper, submitted to the *Journal of Magnetic Resonance (JMR)*, addresses a problem encountered in this new imaging method in the presence of electromagnetic shielding, presents a theoretical model describing the ghost effect and provides a foundation for correction of such artifacts.

The present Issue contains also three highlights (STH15 - STH17) on recently published important papers in superconducting electronics, and STH18 highlighting yet unpublished results on a 25 tesla high-Tc magnet insert for the Chinese ExCES facility currently in development.